

Freeform Search

Database:	US Pre-Grant Publication Full-Text Database US Patents Full-Text Database US OCR Full-Text Database EPO Abstracts Database JPO Abstracts Database Derwent World Patents Index IBM Technical Disclosure Bulletins
Term:	L6 and lot number
Display:	<input type="text" value="15"/> Documents in Display Format: <input type="text" value=""/> Starting with Number <input type="text" value="1"/>
Generate: <input type="radio"/> Hit List <input checked="" type="radio"/> Hit Count <input type="radio"/> Side by Side <input type="radio"/> Image	

Search

Clear

Interrupt

Search History

DATE: Monday, August 16, 2004 [Printable Copy](#) [Create Case](#)

<u>Set</u> <u>Name</u> <u>Query</u>	<u>Hit</u> <u>Count</u>	<u>Set</u> <u>Nam</u> <u>resul</u> <u>set</u>
side by side		
<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ</i>		
<u>L7</u> L6 and lot number	25	<u>L7</u>
<u>L6</u> L2 and histogram	93	<u>L6</u>
<u>L5</u> ("5256578" "5761064" "5838951" "6016562" "6477685" "6559662" "6567168").PN.	19	<u>L5</u>
<u>L4</u> ("6524881" "6559457" "20030003688A1").PN.	4	<u>L4</u>
<u>L3</u> L2 and inspection parameter	42	<u>L3</u>
<u>L2</u> wafer defect	1384	<u>L2</u>
<u>L1</u> hollington and wafer defect	1	<u>L1</u>

END OF SEARCH HISTORY

For 10/604685